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### **Understanding Embedded - FPGAs (Field Programmable Gate Array)**

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

### **Applications of Embedded - FPGAs**

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

#### **Details**

Product Status	Active
Number of LABs/CLBs	2880
Number of Logic Elements/Cells	-
Total RAM Bits	-
Number of I/O	174
Number of Gates	48000
Voltage - Supply	3V ~ 3.6V, 4.75V ~ 5.25V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 70°C (TA)
Package / Case	208-BFQFP
Supplier Device Package	208-PQFP (28x28)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/microchip-technology/a54sx32-2pqq208">https://www.e-xfl.com/product-detail/microchip-technology/a54sx32-2pqq208</a>

The R-cell contains a flip-flop featuring asynchronous clear, asynchronous preset, and clock enable (using the S0 and S1 lines) control signals (Figure 1-2). The R-cell registers feature programmable clock polarity selectable on a register-by-register basis. This provides additional

flexibility while allowing mapping of synthesized functions into the SX FPGA. The clock source for the R-cell can be chosen from either the hardwired clock or the routed clock.

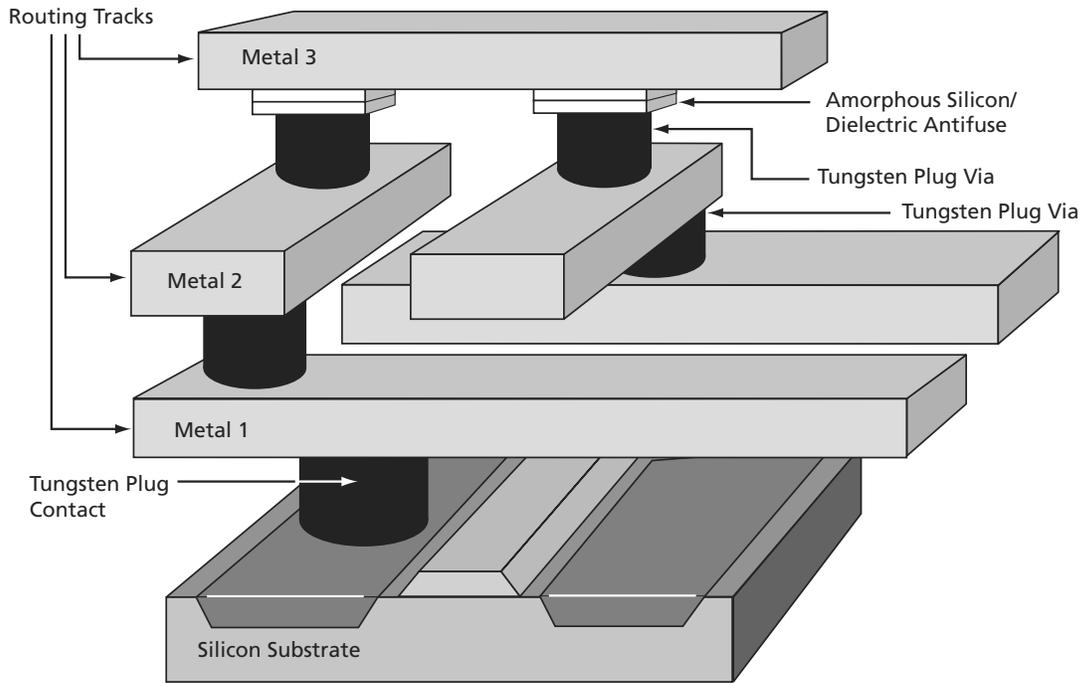


Figure 1-1 • SX Family Interconnect Elements

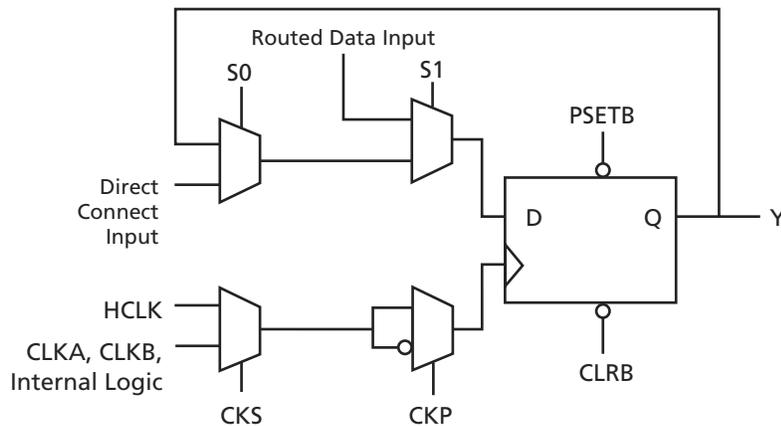


Figure 1-2 • R-Cell

The C-cell implements a range of combinatorial functions up to 5-inputs (Figure 1-3 on page 1-3). Inclusion of the DB input and its associated inverter function dramatically increases the number of combinatorial functions that can be implemented in a single module from 800 options in previous architectures to more than 4,000 in the SX architecture. An example of the improved flexibility

enabled by the inversion capability is the ability to integrate a 3-input exclusive-OR function into a single C-cell. This facilitates construction of 9-bit parity-tree functions with 2 ns propagation delays. At the same time, the C-cell structure is extremely synthesis friendly, simplifying the overall design and reducing synthesis time.

Table 1-4 • Recommended Operating Conditions

Parameter	Commercial	Industrial	Military	Units
Temperature Range*	0 to + 70	-40 to + 85	-55 to +125	°C
3.3 V Power Supply Tolerance	±10	±10	±10	%V <sub>CC</sub>
5.0 V Power Supply Tolerance	±5	±10	±10	%V <sub>CC</sub>

**Note:** \*Ambient temperature ( $T_A$ ) is used for commercial and industrial; case temperature ( $T_C$ ) is used for military.

Table 1-5 • Electrical Specifications

Symbol	Parameter	Commercial		Industrial		Units
		Min.	Max.	Min.	Max.	
V <sub>OH</sub>	(I <sub>OH</sub> = -20 μA) (CMOS) (I <sub>OH</sub> = -8 mA) (TTL) (I <sub>OH</sub> = -6 mA) (TTL)	(V <sub>CCI</sub> - 0.1) 2.4	V <sub>CCI</sub> V <sub>CCI</sub>	(V <sub>CCI</sub> - 0.1) 2.4	V <sub>CCI</sub> V <sub>CCI</sub>	V
V <sub>OL</sub>	(I <sub>OL</sub> = 20 μA) (CMOS) (I <sub>OL</sub> = 12 mA) (TTL) (I <sub>OL</sub> = 8 mA) (TTL)		0.10 0.50		0.50	V
V <sub>IL</sub>			0.8		0.8	V
V <sub>IH</sub>		2.0		2.0		V
t <sub>R</sub> , t <sub>F</sub>	Input Transition Time t <sub>R</sub> , t <sub>F</sub>		50		50	ns
C <sub>IO</sub>	C <sub>IO</sub> I/O Capacitance		10		10	pF
I <sub>CC</sub>	Standby Current, I <sub>CC</sub>		4.0		4.0	mA
I <sub>CC(D)</sub>	I <sub>CC(D)</sub> I <sub>Dynamic</sub> V <sub>CC</sub> Supply Current	See "Evaluating Power in SX Devices" on page 1-16.				

## PCI Compliance for the SX Family

The SX family supports 3.3 V and 5.0 V PCI and is compliant with the PCI Local Bus Specification Rev. 2.1.

Table 1-6 • A54SX16P DC Specifications (5.0 V PCI Operation)

Symbol	Parameter	Condition	Min.	Max.	Units
V <sub>CCA</sub>	Supply Voltage for Array		3.0	3.6	V
V <sub>CCR</sub>	Supply Voltage required for Internal Biasing		4.75	5.25	V
V <sub>CCI</sub>	Supply Voltage for I/Os		4.75	5.25	V
V <sub>IH</sub>	Input High Voltage <sup>1</sup>		2.0	V <sub>CC</sub> + 0.5	V
V <sub>IL</sub>	Input Low Voltage <sup>1</sup>		-0.5	0.8	V
I <sub>IH</sub>	Input High Leakage Current	V <sub>IN</sub> = 2.7		70	μA
I <sub>IL</sub>	Input Low Leakage Current	V <sub>IN</sub> = 0.5		-70	μA
V <sub>OH</sub>	Output High Voltage	I <sub>OUT</sub> = -2 mA	2.4		V
V <sub>OL</sub>	Output Low Voltage <sup>2</sup>	I <sub>OUT</sub> = 3 mA, 6 mA		0.55	V
C <sub>IN</sub>	Input Pin Capacitance <sup>3</sup>			10	pF
C <sub>CLK</sub>	CLK Pin Capacitance		5	12	pF
C <sub>IDSEL</sub>	IDSEL Pin Capacitance <sup>4</sup>			8	pF

### Notes:

1. Input leakage currents include hi-Z output leakage for all bidirectional buffers with tristate outputs.
2. Signals without pull-up resistors must have 3 mA low output current. Signals requiring pull-up must have 6 mA; the latter include, FRAME#, IRDY#, TRDY#, DEVSEL#, STOP#, SERR#, PERR#, LOCK#, and, when used, AD[63::32], C/BE[7::4]#, PAR64, REQ64#, and ACK64#.
3. Absolute maximum pin capacitance for a PCI input is 10 pF (except for CLK).
4. Lower capacitance on this input-only pin allows for non-resistive coupling to AD[xx].

Figure 1-9 shows the 5.0 V PCI V/I curve and the minimum and maximum PCI drive characteristics of the A54SX16P device.

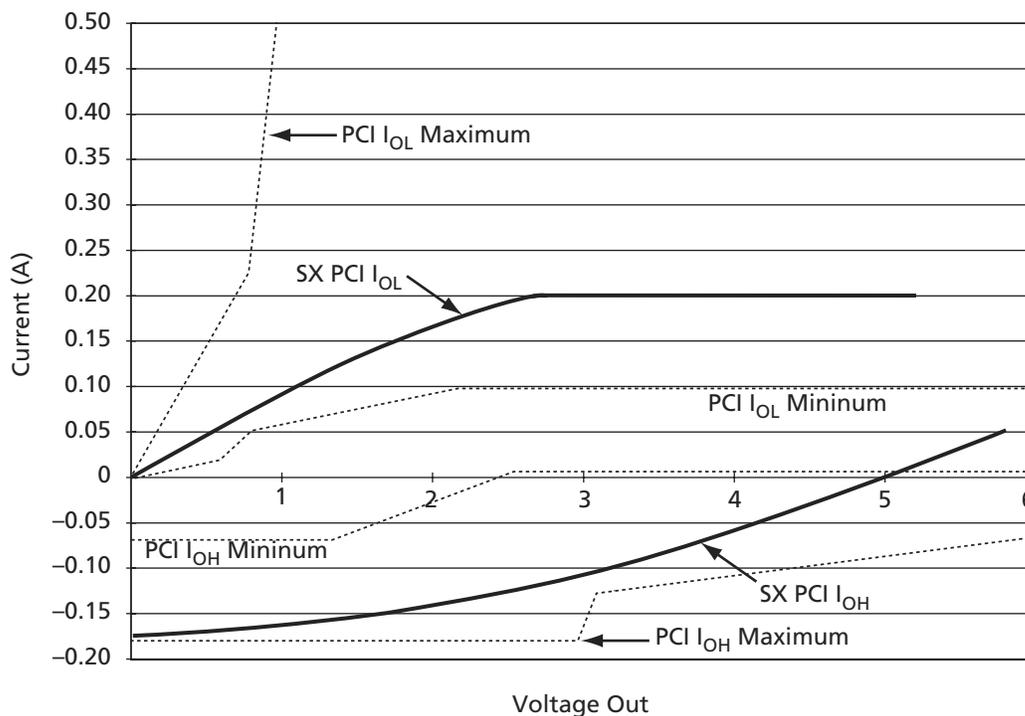


Figure 1-9 • 5.0 V PCI Curve for A54SX16P Device

$$I_{OH} = 11.9 \times (V_{OUT} - 5.25) \times (V_{OUT} + 2.45)$$

for  $V_{CC} > V_{OUT} > 3.1$  V

EQ 1-1

$$I_{OL} = 78.5 \times V_{OUT} \times (4.4 - V_{OUT})$$

for  $0$  V  $< V_{OUT} < 0.71$  V

EQ 1-2

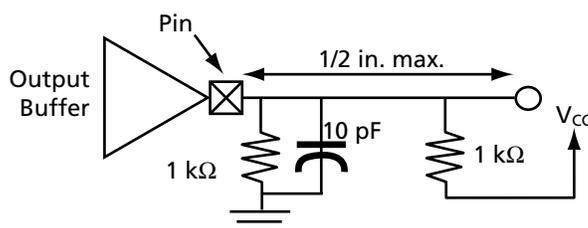
## A54SX16P AC Specifications (3.3 V PCI Operation)

Table 1-9 • A54SX16P AC Specifications (3.3 V PCI Operation)

Symbol	Parameter	Condition	Min.	Max.	Units
$I_{OH(AC)}$	Switching Current High	$0 < V_{OUT} \leq 0.3V_{CC}^1$			mA
		$0.3V_{CC} \leq V_{OUT} < 0.9V_{CC}^1$	$-12V_{CC}$		mA
		$0.7V_{CC} < V_{OUT} < V_{CC}^{1,2}$	$-17.1 + (V_{CC} - V_{OUT})$	EQ 1-3 on page 1-14	
	(Test Point)	$V_{OUT} = 0.7V_{CC}^2$		$-32V_{CC}$	mA
$I_{OL(AC)}$	Switching Current High	$V_{CC} > V_{OUT} \geq 0.6V_{CC}^1$			mA
		$0.6V_{CC} > V_{OUT} > 0.1V_{CC}^1$	$16V_{CC}$		mA
		$0.18V_{CC} > V_{OUT} > 0^{1,2}$	$26.7V_{OUT}$	EQ 1-4 on page 1-14	mA
	(Test Point)	$V_{OUT} = 0.18V_{CC}^2$		$38V_{CC}$	
$I_{CL}$	Low Clamp Current	$-3 < V_{IN} \leq -1$	$-25 + (V_{IN} + 1)/0.015$		mA
$I_{CH}$	High Clamp Current	$-3 < V_{IN} \leq -1$	$25 + (V_{IN} - V_{OUT} - 1)/0.015$		mA
$slew_R$	Output Rise Slew Rate <sup>3</sup>	0.2V <sub>CC</sub> to 0.6V <sub>CC</sub> load	1	4	V/ns
$slew_F$	Output Fall Slew Rate <sup>3</sup>	0.6V <sub>CC</sub> to 0.2V <sub>CC</sub> load	1	4	V/ns

**Notes:**

1. Refer to the V/I curves in Figure 1-10 on page 1-14. Switching current characteristics for REQ# and GNT# are permitted to be one half of that specified here; i.e., half size output drivers may be used on these signals. This specification does not apply to CLK and RST# which are system outputs. "Switching Current High" specification are not relevant to SERR#, INTA#, INTB#, INTC#, and INTD# which are open drain outputs.
2. Maximum current requirements must be met as drivers pull beyond the last step voltage. Equations defining these maximums (C and D) are provided with the respective diagrams in Figure 1-10 on page 1-14. The equation defined maxima should be met by design. In order to facilitate component testing, a maximum current test point is defined for each side of the output driver.
3. This parameter is to be interpreted as the cumulative edge rate across the specified range, rather than the instantaneous rate at any point within the transition range. The specified load (diagram below) is optional; i.e., the designer may elect to meet this parameter with an unloaded output per the latest revision of the PCI Local Bus Specification. However, adherence to both maximum and minimum parameters is required (the maximum is no longer simply a guideline). Rise slew rate does not apply to open drain outputs.



## Power-Up Sequencing

Table 1-10 • Power-Up Sequencing

V <sub>CCA</sub>	V <sub>CCR</sub>	V <sub>CCI</sub>	Power-Up Sequence	Comments
<b>A54SX08, A54SX16, A54SX32</b>				
3.3 V	5.0 V	3.3 V	5.0 V First 3.3 V Second	No possible damage to device
			3.3 V First 5.0 V Second	Possible damage to device
<b>A54SX16P</b>				
3.3 V	3.3 V	3.3 V	3.3 V Only	No possible damage to device
3.3 V	5.0 V	3.3 V	5.0 V First 3.3 V Second	No possible damage to device
			3.3 V First 5.0 V Second	Possible damage to device
3.3 V	5.0 V	5.0 V	5.0 V First 3.3 V Second	No possible damage to device
			3.3 V First 5.0 V Second	No possible damage to device

**Note:** No inputs should be driven (high or low) before completion of power-up.

## Power-Down Sequencing

Table 1-11 • Power-Down Sequencing

V <sub>CCA</sub>	V <sub>CCR</sub>	V <sub>CCI</sub>	Power-Down Sequence	Comments
<b>A54SX08, A54SX16, A54SX32</b>				
3.3 V	5.0 V	3.3 V	5.0 V First 3.3 V Second	Possible damage to device
			3.3 V First 5.0 V Second	No possible damage to device
<b>A54SX16P</b>				
3.3 V	3.3 V	3.3 V	3.3 V Only	No possible damage to device
3.3 V	5.0 V	3.3 V	5.0 V First 3.3 V Second	Possible damage to device
			3.3 V First 5.0 V Second	No possible damage to device
3.3 V	5.0 V	5.0 V	5.0 V First 3.3 V Second	No possible damage to device
			3.3 V First 5.0 V Second	No possible damage to device

**Note:** No inputs should be driven (high or low) after the beginning of the power-down sequence.

## Evaluating Power in SX Devices

A critical element of system reliability is the ability of electronic devices to safely dissipate the heat generated during operation. The thermal characteristics of a circuit depend on the device and package used, the operating temperature, the operating current, and the system's ability to dissipate heat.

You should complete a power evaluation early in the design process to help identify potential heat-related problems in the system and to prevent the system from exceeding the device's maximum allowed junction temperature.

The actual power dissipated by most applications is significantly lower than the power the package can dissipate. However, a thermal analysis should be performed for all projects. To perform a power evaluation, follow these steps:

1. Estimate the power consumption of the application.
2. Calculate the maximum power allowed for the device and package.
3. Compare the estimated power and maximum power values.

## Estimating Power Consumption

The total power dissipation for the SX family is the sum of the DC power dissipation and the AC power dissipation. Use EQ 1-5 to calculate the estimated power consumption of your application.

$$P_{\text{Total}} = P_{\text{DC}} + P_{\text{AC}}$$

EQ 1-5

## DC Power Dissipation

The power due to standby current is typically a small component of the overall power. The Standby power is shown in Table 1-12 for commercial, worst-case conditions (70°C).

Table 1-12 • Standby Power

I <sub>CC</sub>	V <sub>CC</sub>	Power
4 mA	3.6 V	14.4 mW

The DC power dissipation is defined in EQ 1-6.

$$P_{\text{DC}} = (I_{\text{standby}}) \times V_{\text{CCA}} + (I_{\text{standby}}) \times V_{\text{CCR}} + (I_{\text{standby}}) \times V_{\text{CCI}} + xV_{\text{OL}} \times I_{\text{OL}} + y(V_{\text{CCI}} - V_{\text{OH}}) \times V_{\text{OH}}$$

EQ 1-6

## AC Power Dissipation

The power dissipation of the SX Family is usually dominated by the dynamic power dissipation. Dynamic power dissipation is a function of frequency, equivalent capacitance, and power supply voltage. The AC power dissipation is defined in EQ 1-7 and EQ 1-8.

$$P_{\text{AC}} = P_{\text{Module}} + P_{\text{RCLKA Net}} + P_{\text{RCLKB Net}} + P_{\text{HCLK Net}} + P_{\text{Output Buffer}} + P_{\text{Input Buffer}}$$

EQ 1-7

$$P_{\text{AC}} = V_{\text{CCA}}^2 \times [(m \times C_{\text{EQM}} \times f_m)_{\text{Module}} + (n \times C_{\text{EQI}} \times f_n)_{\text{Input Buffer}} + (p \times (C_{\text{EQO}} + C_L) \times f_p)_{\text{Output Buffer}} + (0.5 \times (q_1 \times C_{\text{EQCR}} \times f_{q1}) + (r_1 \times f_{q1}))_{\text{RCLKA}} + (0.5 \times (q_2 \times C_{\text{EQCR}} \times f_{q2}) + (r_2 \times f_{q2}))_{\text{RCLKB}} + (0.5 \times (s_1 \times C_{\text{EQHV}} \times f_{s1}) + (C_{\text{EQHF}} \times f_{s1}))_{\text{HCLK}}]$$

EQ 1-8

### Definition of Terms Used in Formula

- m = Number of logic modules switching at  $f_m$
- n = Number of input buffers switching at  $f_n$
- p = Number of output buffers switching at  $f_p$
- $q_1$  = Number of clock loads on the first routed array clock
- $q_2$  = Number of clock loads on the second routed array clock
- x = Number of I/Os at logic low
- y = Number of I/Os at logic high
- $r_1$  = Fixed capacitance due to first routed array clock
- $r_2$  = Fixed capacitance due to second routed array clock
- $s_1$  = Number of clock loads on the dedicated array clock
- $C_{\text{EQM}}$  = Equivalent capacitance of logic modules in pF
- $C_{\text{EQI}}$  = Equivalent capacitance of input buffers in pF
- $C_{\text{EQO}}$  = Equivalent capacitance of output buffers in pF
- $C_{\text{EQCR}}$  = Equivalent capacitance of routed array clock in pF
- $C_{\text{EQHV}}$  = Variable capacitance of dedicated array clock
- $C_{\text{EQHF}}$  = Fixed capacitance of dedicated array clock
- $C_L$  = Output lead capacitance in pF
- $f_m$  = Average logic module switching rate in MHz
- $f_n$  = Average input buffer switching rate in MHz
- $f_p$  = Average output buffer switching rate in MHz
- $f_{q1}$  = Average first routed array clock rate in MHz
- $f_{q2}$  = Average second routed array clock rate in MHz
- $f_{s1}$  = Average dedicated array clock rate in MHz

Table 1-13 shows capacitance values for various devices.

Table 1-13 • Capacitance Values for Devices

	A545X08	A545X16	A545X16P	A545X32
C <sub>EQM</sub> (pF)	4.0	4.0	4.0	4.0
C <sub>EQI</sub> (pF)	3.4	3.4	3.4	3.4
C <sub>EQO</sub> (pF)	4.7	4.7	4.7	4.7
C <sub>EQCR</sub> (pF)	1.6	1.6	1.6	1.6
C <sub>EQHV</sub>	0.615	0.615	0.615	0.615
C <sub>EQHF</sub>	60	96	96	140
r <sub>1</sub> (pF)	87	138	138	171
r <sub>2</sub> (pF)	87	138	138	171

Table 1-14 • Power Consumption Guidelines

Description	Power Consumption Guideline
Logic Modules (m)	20% of modules
Inputs Switching (n)	# inputs/4
Outputs Switching (p)	# outputs/4
First Routed Array Clock Loads (q <sub>1</sub> )	20% of register cells
Second Routed Array Clock Loads (q <sub>2</sub> )	20% of register cells
Load Capacitance (C <sub>L</sub> )	35 pF
Average Logic Module Switching Rate (f <sub>m</sub> )	f/10
Average Input Switching Rate (f <sub>n</sub> )	f/5
Average Output Switching Rate (f <sub>p</sub> )	f/10
Average First Routed Array Clock Rate (f <sub>q1</sub> )	f/2
Average Second Routed Array Clock Rate (f <sub>q2</sub> )	f/2
Average Dedicated Array Clock Rate (f <sub>s1</sub> )	f
Dedicated Clock Array Clock Loads (s <sub>1</sub> )	20% of regular modules

Follow the steps below to estimate power consumption. The values provided for the sample calculation below are for the shift register design above. This method for estimating power consumption is conservative and the actual power consumption of your design may be less than the estimated power consumption.

The total power dissipation for the SX family is the sum of the AC power dissipation and the DC power dissipation.

$$P_{\text{Total}} = P_{\text{AC}} \text{ (dynamic power)} + P_{\text{DC}} \text{ (static power)}$$

EQ 1-9

## Guidelines for Calculating Power Consumption

The power consumption guidelines are meant to represent worst-case scenarios so that they can be generally used to predict the upper limits of power dissipation. These guidelines are shown in Table 1-14.

### Sample Power Calculation

One of the designs used to characterize the SX family was a 528 bit serial-in, serial-out shift register. The design utilized 100 percent of the dedicated flip-flops of an A545X16P device. A pattern of 0101... was clocked into the device at frequencies ranging from 1 MHz to 200 MHz. Shifting in a series of 0101... caused 50 percent of the flip-flops to toggle from low to high at every clock cycle.

### AC Power Dissipation

$$P_{\text{AC}} = P_{\text{Module}} + P_{\text{RCLKA Net}} + P_{\text{RCLKB Net}} + P_{\text{HCLK Net}} + P_{\text{Output Buffer}} + P_{\text{Input Buffer}}$$

EQ 1-10

$$P_{\text{AC}} = V_{\text{CCA}}^2 \times [(m \times C_{\text{EQM}} \times f_m)_{\text{Module}} + (n \times C_{\text{EQI}} \times f_n)_{\text{Input Buffer}} + (p \times (C_{\text{EQO}} + C_L) \times f_p)_{\text{Output Buffer}} + (0.5 (q_1 \times C_{\text{EQCR}} \times f_{q1}) + (r_1 \times f_{q1}))_{\text{RCLKA}} + (0.5 (q_2 \times C_{\text{EQCR}} \times f_{q2}) + (r_2 \times f_{q2}))_{\text{RCLKB}} + (0.5 (s_1 \times C_{\text{EQHV}} \times f_{s1}) + (C_{\text{EQHF}} \times f_{s1}))_{\text{HCLK}}]$$

EQ 1-11

Figure 1-11 shows the characterized power dissipation numbers for the shift register design using frequencies ranging from 1 MHz to 200 MHz.

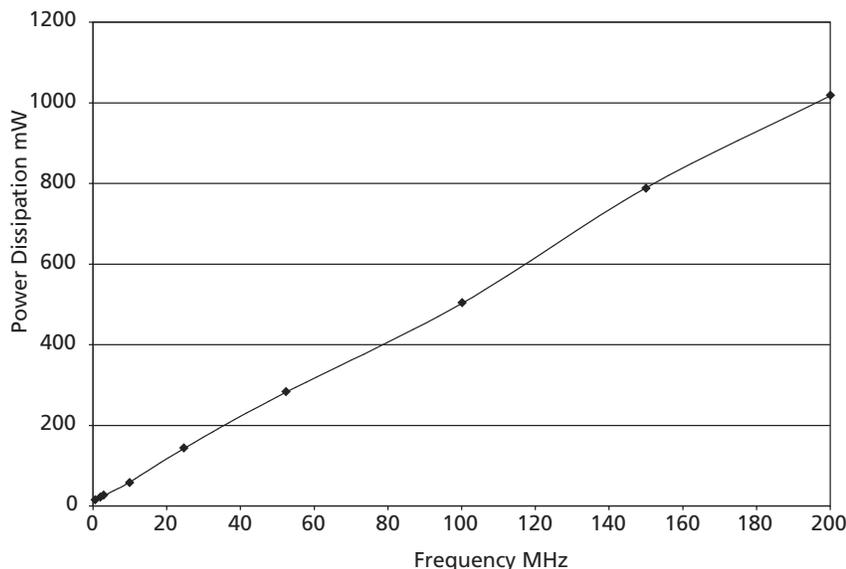


Figure 1-11 • Power Dissipation

## Junction Temperature ( $T_j$ )

The temperature that you select in Designer Series software is the junction temperature, not ambient temperature. This is an important distinction because the heat generated from dynamic power consumption is usually hotter than the ambient temperature. Use the equation below to calculate junction temperature.

$$\text{Junction Temperature} = \Delta T + T_a$$

EQ 1-13

Where:

$T_a$  = Ambient Temperature

$\Delta T$  = Temperature gradient between junction (silicon) and ambient

$$\Delta T = \theta_{ja} \times P$$

$P$  = Power calculated from Estimating Power Consumption section

$\theta_{ja}$  = Junction to ambient of package.  $\theta_{ja}$  numbers are located in the "Package Thermal Characteristics" section.

## Package Thermal Characteristics

The device junction to case thermal characteristic is  $\theta_{jc}$ , and the junction to ambient air characteristic is  $\theta_{ja}$ . The thermal characteristics for  $\theta_{ja}$  are shown with two different air flow rates.

The maximum junction temperature is 150 °C.

A sample calculation of the absolute maximum power dissipation allowed for a TQFP 176-pin package at commercial temperature and still air is as follows:

$$\text{Maximum Power Allowed} = \frac{\text{Max. junction temp. (}^\circ\text{C)} - \text{Max. ambient temp. (}^\circ\text{C)}}{\theta_{ja} \text{ (}^\circ\text{C/W)}} = \frac{150^\circ\text{C} - 70^\circ\text{C}}{28^\circ\text{C/W}} = 2.86 \text{ W}$$

EQ 1-14

Table 1-15 • Package Thermal Characteristics

Package Type	Pin Count	$\theta_{jc}$	$\theta_{ja}$ Still Air	$\theta_{ja}$ 300 ft/min.	Units
Plastic Leaded Chip Carrier (PLCC)	84	12	32	22	°C/W
Thin Quad Flat Pack (TQFP)	144	11	32	24	°C/W
Thin Quad Flat Pack (TQFP)	176	11	28	21	°C/W
Very Thin Quad Flatpack (VQFP)	100	10	38	32	°C/W
Plastic Quad Flat Pack (PQFP) without Heat Spreader	208	8	30	23	°C/W
Plastic Quad Flat Pack (PQFP) with Heat Spreader	208	3.8	20	17	°C/W
Plastic Ball Grid Array (PBGA)	272	3	20	14.5	°C/W
Plastic Ball Grid Array (PBGA)	313	3	23	17	°C/W
Plastic Ball Grid Array (PBGA)	329	3	18	13.5	°C/W
Fine Pitch Ball Grid Array (FBGA)	144	3.8	38.8	26.7	°C/W

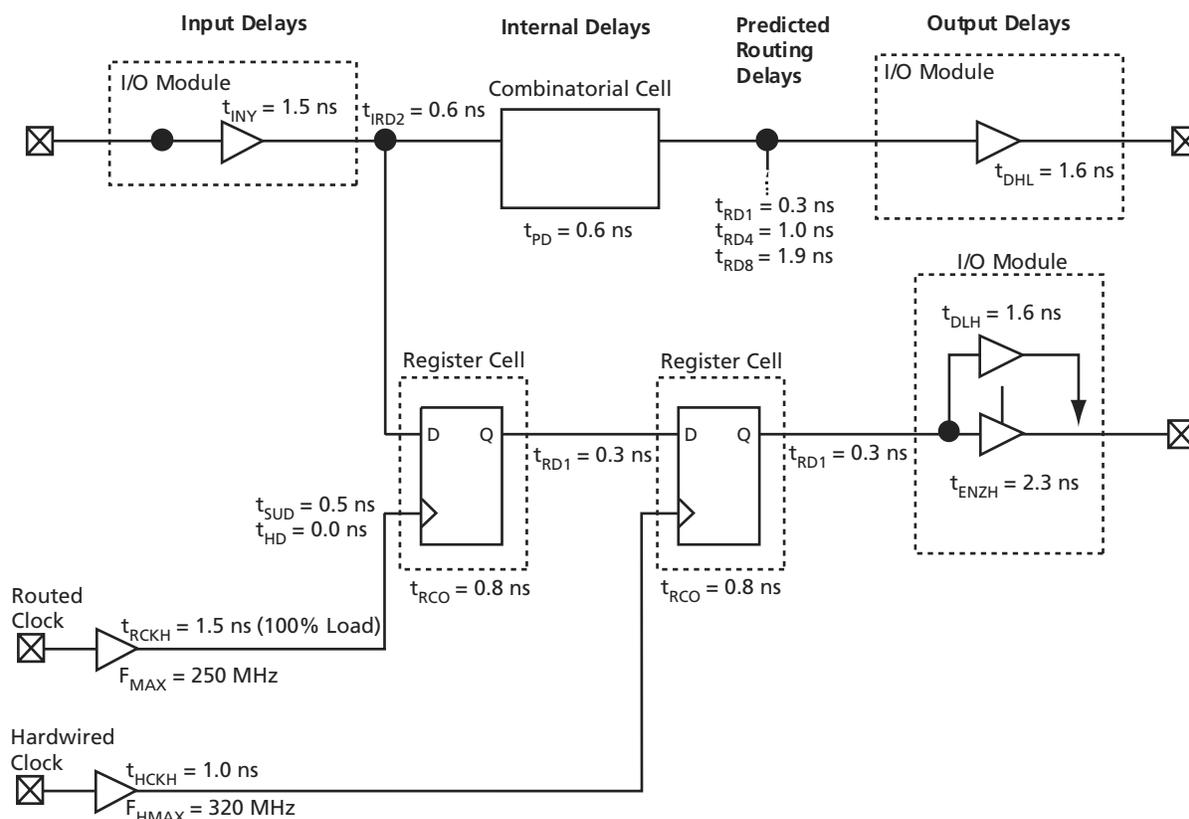
**Note:** SX08 does not have a heat spreader.

Table 1-16 • Temperature and Voltage Derating Factors\*

$V_{CCA}$	Junction Temperature						
	-55	-40	0	25	70	85	125
3.0	0.75	0.78	0.87	0.89	1.00	1.04	1.16
3.3	0.70	0.73	0.82	0.83	0.93	0.97	1.08
3.6	0.66	0.69	0.77	0.78	0.87	0.92	1.02

**Note:** \*Normalized to worst-case commercial,  $T_J = 70^\circ\text{C}$ ,  $V_{CCA} = 3.0\text{ V}$

# SX Timing Model



**Note:** Values shown for A54SX08-3, worst-case commercial conditions.

Figure 1-12 • SX Timing Model

## Hardwired Clock

$$\begin{aligned} \text{External Setup} &= t_{INY} + t_{IRD1} + t_{SUD} - t_{HCKH} \\ &= 1.5 + 0.3 + 0.5 - 1.0 = 1.3 \text{ ns} \end{aligned}$$

EQ 1-15

## Clock-to-Out (Pin-to-Pin)

$$\begin{aligned} &= t_{HCKH} + t_{RCO} + t_{RD1} + t_{DHL} \\ &= 1.0 + 0.8 + 0.3 + 1.6 = 3.7 \text{ ns} \end{aligned}$$

EQ 1-16

## Routed Clock

$$\begin{aligned} \text{External Setup} &= t_{INY} + t_{IRD1} + t_{SUD} - t_{RCKH} \\ &= 1.5 + 0.3 + 0.5 - 1.5 = 0.8 \text{ ns} \end{aligned}$$

EQ 1-17

## Clock-to-Out (Pin-to-Pin)

$$\begin{aligned} &= t_{RCKH} + t_{RCO} + t_{RD1} + t_{DHL} \\ &= 1.52 + 0.8 + 0.3 + 1.6 = 4.2 \text{ ns} \end{aligned}$$

EQ 1-18

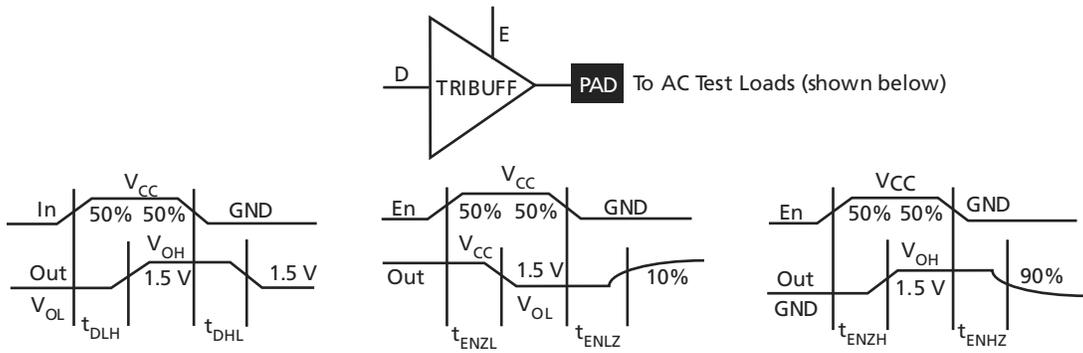


Figure 1-13 • Output Buffer Delays

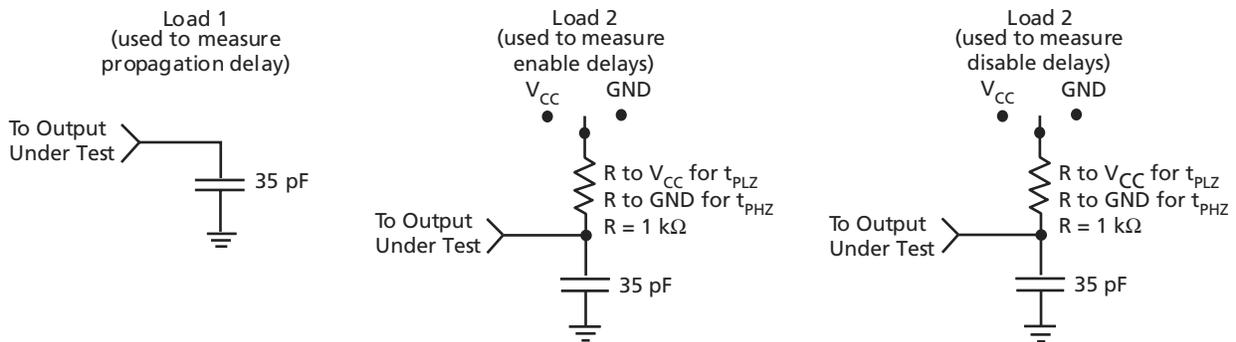


Figure 1-14 • AC Test Loads

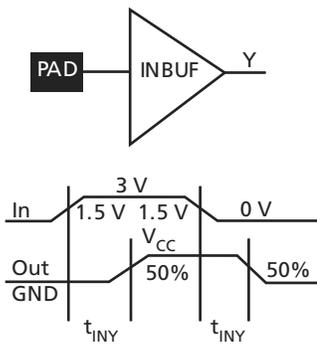


Figure 1-15 • Input Buffer Delays

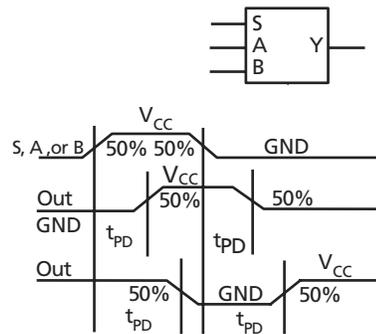


Figure 1-16 • C-Cell Delays

## A54SX16 Timing Characteristics

Table 1-18 • A54SX16 Timing Characteristics  
(Worst-Case Commercial Conditions,  $V_{CCR} = 4.75\text{ V}$ ,  $V_{CCA}, V_{CCI} = 3.0\text{ V}$ ,  $T_J = 70^\circ\text{C}$ )

Parameter	Description	'-3' Speed		'-2' Speed		'-1' Speed		'Std' Speed		Units
		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
<b>C-Cell Propagation Delays<sup>1</sup></b>										
$t_{PD}$	Internal Array Module		0.6		0.7		0.8		0.9	ns
<b>Predicted Routing Delays<sup>2</sup></b>										
$t_{DC}$	FO = 1 Routing Delay, Direct Connect		0.1		0.1		0.1		0.1	ns
$t_{FC}$	FO = 1 Routing Delay, Fast Connect		0.3		0.4		0.4		0.5	ns
$t_{RD1}$	FO = 1 Routing Delay		0.3		0.4		0.4		0.5	ns
$t_{RD2}$	FO = 2 Routing Delay		0.6		0.7		0.8		0.9	ns
$t_{RD3}$	FO = 3 Routing Delay		0.8		0.9		1.0		1.2	ns
$t_{RD4}$	FO = 4 Routing Delay		1.0		1.2		1.4		1.6	ns
$t_{RD8}$	FO = 8 Routing Delay		1.9		2.2		2.5		2.9	ns
$t_{RD12}$	FO = 12 Routing Delay		2.8		3.2		3.7		4.3	ns
<b>R-Cell Timing</b>										
$t_{RCO}$	Sequential Clock-to-Q		0.8		1.1		1.2		1.4	ns
$t_{CLR}$	Asynchronous Clear-to-Q		0.5		0.6		0.7		0.8	ns
$t_{PRESET}$	Asynchronous Preset-to-Q		0.7		0.8		0.9		1.0	ns
$t_{SUD}$	Flip-Flop Data Input Set-Up	0.5		0.5		0.7		0.8		ns
$t_{HD}$	Flip-Flop Data Input Hold	0.0		0.0		0.0		0.0		ns
$t_{WASYN}$	Asynchronous Pulse Width	1.4		1.6		1.8		2.1		ns
<b>Input Module Propagation Delays</b>										
$t_{INYH}$	Input Data Pad-to-Y HIGH		1.5		1.7		1.9		2.2	ns
$t_{INYL}$	Input Data Pad-to-Y LOW		1.5		1.7		1.9		2.2	ns
<b>Predicted Input Routing Delays<sup>2</sup></b>										
$t_{IRD1}$	FO = 1 Routing Delay		0.3		0.4		0.4		0.5	ns
$t_{IRD2}$	FO = 2 Routing Delay		0.6		0.7		0.8		0.9	ns
$t_{IRD3}$	FO = 3 Routing Delay		0.8		0.9		1.0		1.2	ns
$t_{IRD4}$	FO = 4 Routing Delay		1.0		1.2		1.4		1.6	ns
$t_{IRD8}$	FO = 8 Routing Delay		1.9		2.2		2.5		2.9	ns
$t_{IRD12}$	FO = 12 Routing Delay		2.8		3.2		3.7		4.3	ns

**Notes:**

- For dual-module macros, use  $t_{PD} + t_{RD1} + t_{PDn}$ ,  $t_{RCO} + t_{RD1} + t_{PDn}$ , or  $t_{PD1} + t_{RD1} + t_{SUD}$ , whichever is appropriate.
- Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual worst-case performance. Post-route timing is based on actual routing delay measurements performed on the device prior to shipment.
- Delays based on 35 pF loading, except  $t_{ENZL}$  and  $t_{ENZH}$ . For  $t_{ENZL}$  and  $t_{ENZH}$ , the loading is 5 pF.

## A54SX16P Timing Characteristics

Table 1-19 • A54SX16P Timing Characteristics  
(Worst-Case Commercial Conditions,  $V_{CCR} = 4.75\text{ V}$ ,  $V_{CCA}, V_{CCI} = 3.0\text{ V}$ ,  $T_J = 70^\circ\text{C}$ )

Parameter	Description	'-3' Speed		'-2' Speed		'-1' Speed		'Std' Speed		Units
		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
<b>C-Cell Propagation Delays<sup>1</sup></b>										
$t_{PD}$	Internal Array Module		0.6		0.7		0.8		0.9	ns
<b>Predicted Routing Delays<sup>2</sup></b>										
$t_{DC}$	FO = 1 Routing Delay, Direct Connect		0.1		0.1		0.1		0.1	ns
$t_{FC}$	FO = 1 Routing Delay, Fast Connect		0.3		0.4		0.4		0.5	ns
$t_{RD1}$	FO = 1 Routing Delay		0.3		0.4		0.4		0.5	ns
$t_{RD2}$	FO = 2 Routing Delay		0.6		0.7		0.8		0.9	ns
$t_{RD3}$	FO = 3 Routing Delay		0.8		0.9		1.0		1.2	ns
$t_{RD4}$	FO = 4 Routing Delay		1.0		1.2		1.4		1.6	ns
$t_{RD8}$	FO = 8 Routing Delay		1.9		2.2		2.5		2.9	ns
$t_{RD12}$	FO = 12 Routing Delay		2.8		3.2		3.7		4.3	ns
<b>R-Cell Timing</b>										
$t_{RCO}$	Sequential Clock-to-Q		0.9		1.1		1.3		1.4	ns
$t_{CLR}$	Asynchronous Clear-to-Q		0.5		0.6		0.7		0.8	ns
$t_{PRESET}$	Asynchronous Preset-to-Q		0.7		0.8		0.9		1.0	ns
$t_{SUD}$	Flip-Flop Data Input Set-Up	0.5		0.5		0.7		0.8		ns
$t_{HD}$	Flip-Flop Data Input Hold	0.0		0.0		0.0		0.0		ns
$t_{WASYN}$	Asynchronous Pulse Width	1.4		1.6		1.8		2.1		ns
<b>Input Module Propagation Delays</b>										
$t_{INYH}$	Input Data Pad-to-Y HIGH		1.5		1.7		1.9		2.2	ns
$t_{INYL}$	Input Data Pad-to-Y LOW		1.5		1.7		1.9		2.2	ns
<b>Predicted Input Routing Delays<sup>2</sup></b>										
$t_{IRD1}$	FO = 1 Routing Delay		0.3		0.4		0.4		0.5	ns
$t_{IRD2}$	FO = 2 Routing Delay		0.6		0.7		0.8		0.9	ns
$t_{IRD3}$	FO = 3 Routing Delay		0.8		0.9		1.0		1.2	ns
$t_{IRD4}$	FO = 4 Routing Delay		1.0		1.2		1.4		1.6	ns
$t_{IRD8}$	FO = 8 Routing Delay		1.9		2.2		2.5		2.9	ns
$t_{IRD12}$	FO = 12 Routing Delay		2.8		3.2		3.7		4.3	ns

**Note:**

- For dual-module macros, use  $t_{PD} + t_{RD1} + t_{PDn}$ ,  $t_{RCO} + t_{RD1} + t_{PDn}$ , or  $t_{PD1} + t_{RD1} + t_{SUD}$ , whichever is appropriate.
- Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual worst-case performance. Post-route timing is based on actual routing delay measurements performed on the device prior to shipment.
- Delays based on 10 pF loading.



84-Pin PLCC	
Pin Number	A54SX08 Function
1	V <sub>CCR</sub>
2	GND
3	V <sub>CCA</sub>
4	PRA, I/O
5	I/O
6	I/O
7	V <sub>CCI</sub>
8	I/O
9	I/O
10	I/O
11	TCK, I/O
12	TDI, I/O
13	I/O
14	I/O
15	I/O
16	TMS
17	I/O
18	I/O
19	I/O
20	I/O
21	I/O
22	I/O
23	I/O
24	I/O
25	I/O
26	I/O
27	GND
28	V <sub>CCI</sub>
29	I/O
30	I/O
31	I/O
32	I/O
33	I/O
34	I/O
35	I/O

84-Pin PLCC	
Pin Number	A54SX08 Function
36	I/O
37	I/O
38	I/O
39	I/O
40	PRB, I/O
41	V <sub>CCA</sub>
42	GND
43	V <sub>CCR</sub>
44	I/O
45	HCLK
46	I/O
47	I/O
48	I/O
49	I/O
50	I/O
51	I/O
52	TDO, I/O
53	I/O
54	I/O
55	I/O
56	I/O
57	I/O
58	I/O
59	V <sub>CCA</sub>
60	V <sub>CCI</sub>
61	GND
62	I/O
63	I/O
64	I/O
65	I/O
66	I/O
67	I/O
68	V <sub>CCA</sub>
69	GND
70	I/O

84-Pin PLCC	
Pin Number	A54SX08 Function
71	I/O
72	I/O
73	I/O
74	I/O
75	I/O
76	I/O
77	I/O
78	I/O
79	I/O
80	I/O
81	I/O
82	I/O
83	CLKA
84	CLKB

144-Pin TQFP			
Pin Number	A54SX08 Function	A54SX16P Function	A54SX32 Function
73	GND	GND	GND
74	I/O	I/O	I/O
75	I/O	I/O	I/O
76	I/O	I/O	I/O
77	I/O	I/O	I/O
78	I/O	I/O	I/O
79	V <sub>CCA</sub>	V <sub>CCA</sub>	V <sub>CCA</sub>
80	V <sub>CCI</sub>	V <sub>CCI</sub>	V <sub>CCI</sub>
81	GND	GND	GND
82	I/O	I/O	I/O
83	I/O	I/O	I/O
84	I/O	I/O	I/O
85	I/O	I/O	I/O
86	I/O	I/O	I/O
87	I/O	I/O	I/O
88	I/O	I/O	I/O
89	V <sub>CCA</sub>	V <sub>CCA</sub>	V <sub>CCA</sub>
90	V <sub>CCR</sub>	V <sub>CCR</sub>	V <sub>CCR</sub>
91	I/O	I/O	I/O
92	I/O	I/O	I/O
93	I/O	I/O	I/O
94	I/O	I/O	I/O
95	I/O	I/O	I/O
96	I/O	I/O	I/O
97	I/O	I/O	I/O
98	V <sub>CCA</sub>	V <sub>CCA</sub>	V <sub>CCA</sub>
99	GND	GND	GND
100	I/O	I/O	I/O
101	GND	GND	GND
102	V <sub>CCI</sub>	V <sub>CCI</sub>	V <sub>CCI</sub>
103	I/O	I/O	I/O
104	I/O	I/O	I/O
105	I/O	I/O	I/O
106	I/O	I/O	I/O
107	I/O	I/O	I/O
108	I/O	I/O	I/O

144-Pin TQFP			
Pin Number	A54SX08 Function	A54SX16P Function	A54SX32 Function
109	GND	GND	GND
110	I/O	I/O	I/O
111	I/O	I/O	I/O
112	I/O	I/O	I/O
113	I/O	I/O	I/O
114	I/O	I/O	I/O
115	V <sub>CCI</sub>	V <sub>CCI</sub>	V <sub>CCI</sub>
116	I/O	I/O	I/O
117	I/O	I/O	I/O
118	I/O	I/O	I/O
119	I/O	I/O	I/O
120	I/O	I/O	I/O
121	I/O	I/O	I/O
122	I/O	I/O	I/O
123	I/O	I/O	I/O
124	I/O	I/O	I/O
125	CLKA	CLKA	CLKA
126	CLKB	CLKB	CLKB
127	V <sub>CCR</sub>	V <sub>CCR</sub>	V <sub>CCR</sub>
128	GND	GND	GND
129	V <sub>CCA</sub>	V <sub>CCA</sub>	V <sub>CCA</sub>
130	I/O	I/O	I/O
131	PRA, I/O	PRA, I/O	PRA, I/O
132	I/O	I/O	I/O
133	I/O	I/O	I/O
134	I/O	I/O	I/O
135	I/O	I/O	I/O
136	I/O	I/O	I/O
137	I/O	I/O	I/O
138	I/O	I/O	I/O
139	I/O	I/O	I/O
140	V <sub>CCI</sub>	V <sub>CCI</sub>	V <sub>CCI</sub>
141	I/O	I/O	I/O
142	I/O	I/O	I/O
143	I/O	I/O	I/O
144	TCK, I/O	TCK, I/O	TCK, I/O

## 176-Pin TQFP

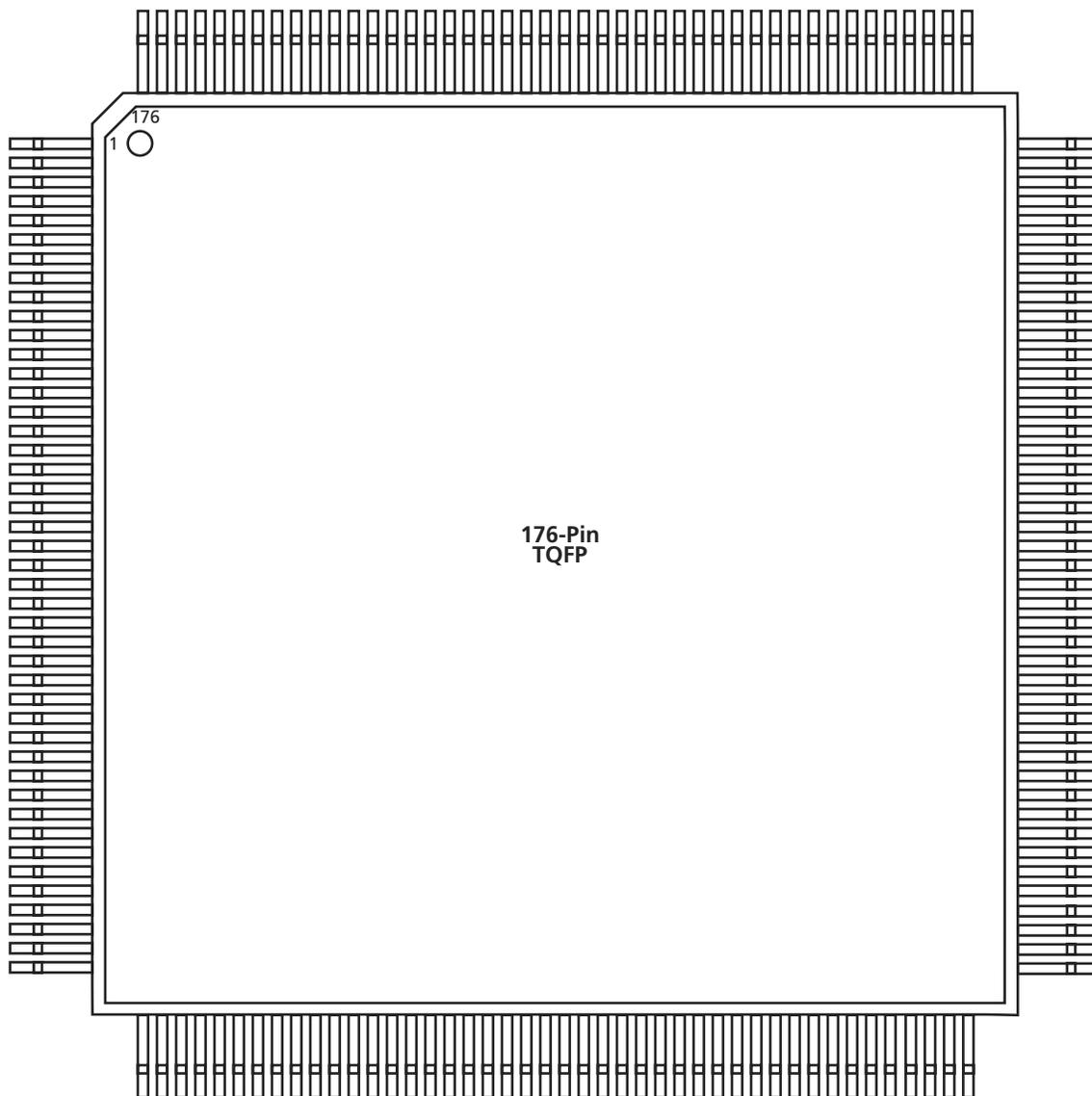


Figure 2-4 • 176-Pin TQFP (Top View)

### Note

For Package Manufacturing and Environmental information, visit the Package Resource center at <http://www.actel.com/products/rescenter/package/index.html>.

176-Pin TQFP			
Pin Number	A545X08 Function	A545X16, A545X16P Function	A545X32 Function
137	I/O	I/O	I/O
138	I/O	I/O	I/O
139	I/O	I/O	I/O
140	V <sub>CCI</sub>	V <sub>CCI</sub>	V <sub>CCI</sub>
141	I/O	I/O	I/O
142	I/O	I/O	I/O
143	I/O	I/O	I/O
144	I/O	I/O	I/O
145	I/O	I/O	I/O
146	I/O	I/O	I/O
147	I/O	I/O	I/O
148	I/O	I/O	I/O
149	I/O	I/O	I/O
150	I/O	I/O	I/O
151	I/O	I/O	I/O
152	CLKA	CLKA	CLKA
153	CLKB	CLKB	CLKB
154	V <sub>CCR</sub>	V <sub>CCR</sub>	V <sub>CCR</sub>
155	GND	GND	GND
156	V <sub>CCA</sub>	V <sub>CCA</sub>	V <sub>CCA</sub>

176-Pin TQFP			
Pin Number	A545X08 Function	A545X16, A545X16P Function	A545X32 Function
157	PRA, I/O	PRA, I/O	PRA, I/O
158	I/O	I/O	I/O
159	I/O	I/O	I/O
160	I/O	I/O	I/O
161	I/O	I/O	I/O
162	I/O	I/O	I/O
163	I/O	I/O	I/O
164	I/O	I/O	I/O
165	I/O	I/O	I/O
166	I/O	I/O	I/O
167	I/O	I/O	I/O
168	NC	I/O	I/O
169	V <sub>CCI</sub>	V <sub>CCI</sub>	V <sub>CCI</sub>
170	I/O	I/O	I/O
171	NC	I/O	I/O
172	NC	I/O	I/O
173	NC	I/O	I/O
174	I/O	I/O	I/O
175	I/O	I/O	I/O
176	TCK, I/O	TCK, I/O	TCK, I/O

329-Pin PBGA	
Pin Number	A54SX32 Function
A1	GND
A2	GND
A3	V <sub>CCI</sub>
A4	NC
A5	I/O
A6	I/O
A7	V <sub>CCI</sub>
A8	NC
A9	I/O
A10	I/O
A11	I/O
A12	I/O
A13	CLKB
A14	I/O
A15	I/O
A16	I/O
A17	I/O
A18	I/O
A19	I/O
A20	I/O
A21	NC
A22	V <sub>CCI</sub>
A23	GND
AA1	V <sub>CCI</sub>
AA2	I/O
AA3	GND
AA4	I/O
AA5	I/O
AA6	I/O
AA7	I/O
AA8	I/O
AA9	I/O
AA10	I/O
AA11	I/O
AA12	I/O

329-Pin PBGA	
Pin Number	A54SX32 Function
AA13	I/O
AA14	I/O
AA15	I/O
AA16	I/O
AA17	I/O
AA18	I/O
AA19	I/O
AA20	TDO, I/O
AA21	V <sub>CCI</sub>
AA22	I/O
AA23	V <sub>CCI</sub>
AB1	I/O
AB2	GND
AB3	I/O
AB4	I/O
AB5	I/O
AB6	I/O
AB7	I/O
AB8	I/O
AB9	I/O
AB10	I/O
AB11	PRB, I/O
AB12	I/O
AB13	HCLK
AB14	I/O
AB15	I/O
AB16	I/O
AB17	I/O
AB18	I/O
AB19	I/O
AB20	I/O
AB21	I/O
AB22	GND
AB23	I/O
AC1	GND

329-Pin PBGA	
Pin Number	A54SX32 Function
AC2	V <sub>CCI</sub>
AC3	NC
AC4	I/O
AC5	I/O
AC6	I/O
AC7	I/O
AC8	I/O
AC9	V <sub>CCI</sub>
AC10	I/O
AC11	I/O
AC12	I/O
AC13	I/O
AC14	I/O
AC15	NC
AC16	I/O
AC17	I/O
AC18	I/O
AC19	I/O
AC20	I/O
AC21	NC
AC22	V <sub>CCI</sub>
AC23	GND
B1	V <sub>CCI</sub>
B2	GND
B3	I/O
B4	I/O
B5	I/O
B6	I/O
B7	I/O
B8	I/O
B9	I/O
B10	I/O
B11	I/O
B12	PRA, I/O
B13	CLKA

329-Pin PBGA	
Pin Number	A54SX32 Function
B14	I/O
B15	I/O
B16	I/O
B17	I/O
B18	I/O
B19	I/O
B20	I/O
B21	I/O
B22	GND
B23	V <sub>CCI</sub>
C1	NC
C2	TDI, I/O
C3	GND
C4	I/O
C5	I/O
C6	I/O
C7	I/O
C8	I/O
C9	I/O
C10	I/O
C11	I/O
C12	I/O
C13	I/O
C14	I/O
C15	I/O
C16	I/O
C17	I/O
C18	I/O
C19	I/O
C20	I/O
C21	V <sub>CCI</sub>
C22	GND
C23	NC
D1	I/O
D2	I/O